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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/828,003	04/06/2001	Eiko Suzuki	14467	5196
23389	7590 06/22/2005		EXAM	INER
SCULLY SCOTT MURPHY & PRESSER, PC			LE, BRIAN Q	
400 GARDEN	I CITY PLAZA			
SUITE 300			ART UNIT	PAPER NUMBER
GARDEN CITY, NY 11530			2623	

DATE MAILED: 06/22/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)			
	09/828,003	SUZUKI, EIKO			
Office Action Summary	Examiner	Art Unit			
	Brian Q. Le	2623			
The MAILING DATE of this communication apperiod for Reply	ppears on the cover sheet with the	correspondence address			
A SHORTENED STATUTORY PERIOD FOR REP THE MAILING DATE OF THIS COMMUNICATION  - Extensions of time may be available under the provisions of 37 CFR 1 after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a re  - If NO period for reply is specified above, the maximum statutory perio Failure to reply within the set or extended period for reply will, by statu- Any reply received by the Office later than three months after the mail earned patent term adjustment. See 37 CFR 1.704(b).	136(a). In no event, however, may a reply be .ply within the statutory minimum of thirty (30) d d will apply and will expire SIX (6) MONTHS fro tte, cause the application to become ABANDON	timely filed  ays will be considered timely.  m the mailing date of this communication.  NED (35 U.S.C. § 133).			
Status					
1) Responsive to communication(s) filed on 18	<u>April 2005</u> .				
2a) ☐ This action is <b>FINAL</b> . 2b) ☑ Th	☐ This action is <b>FINAL</b> . 2b) ☑ This action is non-final.				
3) Since this application is in condition for allowance except for formal matters, prosecution as to the ments is					
closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.					
Disposition of Claims					
4)⊠ Claim(s) <u>1 and 3-12</u> is/are pending in the application.					
4a) Of the above claim(s) is/are withdr	4a) Of the above claim(s) is/are withdrawn from consideration.				
5) Claim(s) is/are allowed.	5) Claim(s) is/are allowed.				
6)⊠ Claim(s) <u>1 and 3-12</u> is/are rejected.					
8) Claim(s) are subject to restriction and	or election requirement.				
Application Papers					
9) The specification is objected to by the Examir	ner.				
	0)☐ The drawing(s) filed on is/are: a)☐ accepted or b)☐ objected to by the Examiner.				
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).					
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).					
11) The oath or declaration is objected to by the E	Examiner. Note the attached Office	ce Action or form PTO-152.			
Priority under 35 U.S.C. § 119					
12) Acknowledgment is made of a claim for foreig a) All b) Some * c) None of: 1. Certified copies of the priority document	nts have been received.				
<ul> <li>2. Certified copies of the priority documents have been received in Application No</li> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage</li> </ul>					
application from the International Bure		ved in this National Stage			
* See the attached detailed Office action for a lis		ved.			
Attachment(s)	•				
1) Notice of References Cited (PTO-892)	4) 🔲 Interview Summa	ry (PTO-413)			
2) Notice of Draftsperson's Patent Drawing Review (PTO-948)	Paper No(s)/Mail I	Date			
<ol> <li>Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08 Paper No(s)/Mail Date</li> </ol>	5) Notice of Informal 6) Other:	Patent Application (PTO-152)			

#### Continued Examination Under 37 CFR 1.114

- 1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 04/18/2005 has been entered.
- 2. PTO-1449 Forms of the IDS filed on December 15, 2004 and April 6, 2001 are missing. The Applicant needs to file them (the form and the references) for consideration.

### Response to Amendment and Arguments

3. Applicant's arguments with regard to claims 1, and 3-12 have been fully considered, but are not considered persuasive because of the following reasons:

Regarding the rejection of claims 5 under 35 U.S.C 112, the Applicant indicates (page 7 and 8 of the 'Remarks') the page 22 of the original specification show the support optical read conditions. However as indicated in the previous Office Action, the original disclosure does not show the interaction/relationship between the first read optical condition and the second read optical condition. The cited portion of the specification only shows the multiple read optical condition but no where it shows the relationship/interaction of the first read optical condition to the second read optical condition as disclosed in the claim language. Similarly to the claim 12, the original disclosure does not show the support of how the first ID interacts/relates to the second ID as claimed. Also the Applicant shows (page 9 of the 'Remarks') that page 18, line 9-page 19, line 16 shows the support of performing digital recognition processing of the first ID and analog recognition processing of the second ID. However, the cited location does not show

the supported for the limitation of claim 12. Also, the Applicant cited page 22, lines 8-13 to show the support for claim language "highest score being adopted only if it is at least equal to a predetermined minimum score". The Examiner respectfully disagrees; the cited location does not show the support for this limitation. It merely shows the evaluation of highest score involving 70. However, it never discloses that 70 is the lowest/minimum score. Another word, 70 score can be a predetermined threshold but it is not necessarily considered as minimum/lowest score. Regarding claims 1-2, 5, 8-9 and 11, the Applicant argues (page 11) that Ono Satoru only teaches the evaluation score for one ID. However paragraph [0001], Ono Satoru clearly indicates this is a processing of more than one ID. Thus, there would be an evaluation score for more than one ID. Thus, all the rejections still maintained until the Applicant overcome the 35 U.S.C 112 rejections and the Prior Arts.

Thus, the rejections of all of the claims are maintained.

#### Claim Rejections - 35 USC § 112

- 4. The following is a quotation of the first paragraph of 35 U.S.C. 112:
  - The specification shall contain a written description of the invention, and of the manner and process of making and using it, in such full, clear, concise, and exact terms as to enable any person skilled in the art to which it pertains, or with which it is most nearly connected, to make and use the same and shall set forth the best mode contemplated by the inventor of carrying out his invention.
- 5. Claims 5-8 and 12 are rejected under 35 U.S.C. 112, first paragraph, as failing to comply with the enablement requirement. The claim(s) contains subject matter which was not described in the specification in such a way as to enable one skilled in the art to which it pertains, or with which it is most nearly connected, to make and/or use the invention. Regarding claims 5, the Examiner finds that the specification does disclose the image sensing optical means which executes retry processing of performing ID recognition in according with first and second read

optical (emphasis added) conditions integration. The portion of the specification merely discloses the change of read optical condition information and does not disclose the ID recognition in accordance to the relationship of second read optical conditions and the first read optical condition as claimed (claim 5). Further details are needed to clarify these claim limitations. Regarding claim 12, the Applicant also does not clearly disclose in the specification referring to a wafer's ID recognition process wherein the ID includes the combination of first ID and second ID from code information and character/numeral information. Furthermore, the Applicant needs to point out where (page and line number) a recognition processing means perform digital recognition processing of the first ID and perform analog recognition on the second ID if no code can be recognized. The Examiner asserts that the Applicant discloses a concept of digital recognition and analog limitation. However, the Applicant does not disclose the claimed limitation. Claims not specifically addressed depend from indefinite antecedent claims. [The original disclosure does not show the interaction/relationship between the first read optical condition and the second read optical condition. The cited portion of the specification only shows the multiple read optical condition but no where it shows the relationship/interaction of the first read optical condition to the second read optical condition as disclosed in the claim language. Similarly to the claim 12, the original disclosure does not show the support of how the first ID interacts/relates to the second ID as claimed. Also the Applicant shows (page 9 of the 'Remarks') that page 18, line 9-page 19, line 16 shows the support of performing digital recognition processing of the first ID and analog recognition processing of the second ID. However, the cited location does not show the supported for the limitation of claim 12. Also, the Applicant cited page 22, lines 8-13 to show the support for claim language "highest score being

adopted only if it is at least equal to a predetermined minimum score". The Examiner respectfully disagrees; the cited location does not show the support for this limitation. It merely shows the evaluation of highest score involving 70. However, it never discloses that 70 is the lowest/minimum score. Another word, 70 score can be a predetermined threshold but it is not necessarily considered as minimum/lowest score.]

6. Claims 1, and 3-12 are rejected under 35 U.S.C. 112, first paragraph, as failing to comply with the written description requirement. The claim(s) contains subject matter which was not described in the specification in such a way as to reasonably convey to one skilled in the relevant art that the inventor(s), at the time the application was filed, had possession of the claimed invention. Regarding claim 1, the original disclosure does not show the support for exhibiting the highest score as an ID of the semiconductor wafer under the read optical condition, the highest score being adopted only if it is at least equal to a predetermined minimum score (emphasis added). Claims not specifically addressed depend from indefinite antecedent claims.

#### Claim Rejections - 35 USC § 102

7. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 8. Claims 1, 5, 8-9, and 11 are rejected under 35 U.S.C. 102(b) as being anticipated by Ono Satoru JP10-227184.

Regarding to claim 1, Ono teaches a semiconductor wafer ID recognition apparatus (Detailed Description, first paragraph) comprising:

Application/Control Number: 09/828,003

Art Unit: 2623

Image sensing optical means for reading at least one identification information character string (ID) marked at an arbitrary position on a semiconductor wafer in accordance with a plurality of first read optical conditions registered in advance (Detailed Description, first paragraph); and

Recognition processing means for performing recognition processing (Detailed Description, page 1, last paragraph) including calculation of an evaluation score representing a read likelihood ratio for an image output from said image sensing optical means for every read optical condition (Detailed Description, page 3, second paragraph and Table 1), and for adopting a recognition result for the character string exhibiting the highest score ("optimum value based on the recognition result") as an ID of the semiconductor wafer under the read optical condition, (Detailed Description, page 4, first 20 lines) the highest score being adopted only if it is at least equal to a predetermined minimum score (the process of able to determine good recognition, reference score/minimum score of 6, and the improper recognition, reference score of 4) (page 3, detailed description, paragraph [0016] and paragraph [0017]),

wherein said recognition processing means performs recognition processing for a corresponding ID among a plurality of IDs recorded on the semiconductor wafer in accordance with the first read optical conditions, and adopts, as the ID of the semiconductor wafer, a recognition result under a read optical condition exhibiting the highest score obtained by recognition processing under all the first read optical conditions (It is the process of calculating the highest score under optical reading conditions) (Detailed Description, page 4, first 20 lines).

Referring to claim 5, please refer back to claim 1 for the explanation.

For claim 8, Ono teaches an apparatus wherein said recognition processing means determines that no ID can be recognized when an evaluation score is under a predetermined value or when an indistinct character exists in a character string of a recognition result (Detailed Description, page 3, second paragraph, table 1, and page 4).

Referring to claim 9, please refer back to claim 1 for previous claimed limitation. In addition, Ono teaches a light source which is arranged to irradiate an ID on the semiconductor wafer and changes in irradiation condition in accordance with the first read optical conditions, and image sensing means for reading the ID on the semiconductor wafer irradiated by said light source (Solution and Means, page 1), and said recognition processing means comprises read optical condition memory means for storing the first read optical conditions, light source control means for controlling said light source so as to set the first read optical conditions stored in said read optical condition memory means (Camera has memory to store the optical conditions) (Solution).

Regarding claim 11, Ono discloses an apparatus further comprising transfer means for transferring the semiconductor wafer to a predetermined position on the basis of the ID adopted by said recognition processing means (Detailed Description, page 2, last 15 lines).

#### Claim Rejections - 35 USC § 103

- 9. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

10. Claims 3, 6-7, and 10 are rejected under 35 U.S.C. 103(a) as being unpatentable over the combination of Ono Satoru JP10-227184 and Hunter U.S. Patent No. 6,697,517 as applied to claim 1 above.

Regarding claim 3, Ono does not clearly teach the apparatus further comprising informing means for generating a warning when no ID can be recognized by recognition processing under the first read optical conditions. Hunter teaches a process of recognizing substrate/wafer that further verify the signature/ID on each substrate through video image and that each signature is verified to ensured if each substrate is by passed (column 13, lines 8-41) that generate warning (column 7, lines 49-57). Thus, it would have been obvious that there is a warning message shows on the video image system to give warning if the signature on a substrate/wafer is not correct. Modifying Ono's method of wafer's ID recognition according to Hunter would able to further help the system to generate warnings if the ID is not correct so that the operator can further correct the wafer's ID. This would improve processing and therefore, it would have been obvious to one of the ordinary skill in the art to modify Ono according to Hunter.

Regarding claims 6-7, please refer back to claim 3 for further explanation.

Regarding claim 10, please refer back to claim 1 for further explanation. However, Ono does not explicitly teaches a memory (a computer system) to store the recognition result said recognition unit and an evaluation result of said evaluation unit. However, Hunter teaches a computer system with memory is used to generate software and store information for the process of recognizing substrate/wafer's ID. Modifying Ono's method of wafer's ID recognition according to Hunter would able to further help the system providing memory for storing the

recognition result and evaluation result of said evaluation unit. This would improve processing and therefore, it would have been obvious to one of the ordinary skill in the art to modify Ono according to Hunter.

## Contact Information

11. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Brian Q Le whose telephone number is 571-272-7424. The examiner can normally be reached on 8:30 A.M - 5:30 P.M.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Amelia Au can be reached on 571-272-7414. The fax phone numbers for the organization where this application or proceeding is assigned are 703-308-5397 for regular communications and 703-308-5397 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-305-3900.

BL June 13, 2005

> SAMIR AHMED PRIMARY EXAMINER